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# High-throughput roll-to-roll X-ray characterization of polymer solar cell active layers†

Arvid P. L. Böttiger,<sup>a</sup> Mikkel Jørgensen,<sup>a</sup> Andreas Menzel,<sup>b</sup> Frederik C. Krebs<sup>a</sup> and Jens W. Andreasen<sup>\*a</sup>

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Synchrotron-based X-rays were used to probe active materials for polymer solar cells on flexible polyester foil. The active material was coated onto a flexible 130 micron thick polyester foil using roll-to-roll differentially pumped slot-die coating and presented variation in composition, thickness, and additives. The coated foil was passed through a synchrotron X-ray beam on a small unit comprising unwinder and winder for the foil, an X-ray probe station, and a barcode reader for sample registration. Foil lengths of 10 meters were probed and yielded X-ray scattering data for approximately every 1 cm, probing linear variations in processing and coating parameters along the foil. The demonstration shows that real-time structural characterization of roll-to-roll coating at realistic web-speeds is feasible using synchrotron radiation. Off-line characterization with lower spatial resolution would be possible with dedicated laboratory instruments. We found that poly(3-hexyl)thiophene (P3HT) only crystallizes at a ratio above 1 : 2 with phenyl-C61-butyric acid methyl ester (PCBM) and that an optimum addition of 2 vol% chloronaphthalene (CN) as a processing additive significantly improves polymer crystallinity and crystallite size. In coated films thinner than 275 nm, textured poly(3-hexyl)thiophene crystallites with the lamellar stack aligned with the substrate dominate, similar to what is observed for spin-coated films.

## Introduction

Some of the defining properties of polymer solar cells are characterized by the tremendous ease and speed with which they can be processed. The typical polymer solar cell is comprised of a multilayer stack of organic and inorganic materials that are processed one after the other using solution-based roll-to-roll coating and printing. For each layer the morphology and interface behavior present an intricate and complex dependency on the processing conditions and parameters. When polymer solar cell films are prepared by spin coating in a batch process, subsequent characterization is comparable in terms of the time required for the preparation, but when each layer is applied in a continuous process, roll-to-roll (R2R), new challenges must be met: the amount of data that needs to be efficiently collected and analyzed to characterize a given process or materials combination scales with the coated area. For the typical R2R coated

polymer solar cell the web speeds employed are in the range of 1–10 m min<sup>−1</sup> using web widths of 305 mm. This implies that an enormous amount of area is coated in a given amount of time compared to the speed at which that same area can be characterized using conventional methods such as optical methods, scanning probe techniques, discrete electrical measurements, and X-ray scattering. Unless the analysis method has the same throughput as the processing methods it is unlikely to be useful as a technique to optimize a given process or materials system. The characterization methods that have been demonstrated in an R2R setting are I–V characterization (current–voltage), optical microscopy, UV-visible spectroscopy, light beam induced current (LBIC), and incident photon to electron conversion efficiency (IPCE).<sup>1,2</sup> In addition to those techniques, ellipsometry, dark lock-in thermography, electroluminescence imaging, and optical coherence tomography have the potential to become R2R compatible.<sup>3–6</sup> Common to all these methods is that they yield macroscopic measures of the polymer solar cell such as structural and functional variations of the solar cells with a resolution of around 100 micron and particle detection down to around 10 micron. If one wishes to explore the microscopic nature of the organic solar cell stack on the micro- or nanoscale, new and rapid characterization tools are needed. One of the most powerful methods to probe the morphology and molecular organization of active materials in polymer solar cells is X-ray scattering methods. Intense synchrotron X-ray light sources allow X-ray characterization to be carried out at speeds compatible with roll-to-roll processing. There are a number of

<sup>a</sup>Department of Energy Conversion and Storage, Technical University of Denmark, Frederiksborgvej 399, DK-4000 Roskilde, Denmark. E-mail: jewa@dtu.dk

<sup>b</sup>Paul Scherrer Institut, 5232 Villigen PSI, Switzerland

† Electronic supplementary information (ESI) available: Quantification of the P3HT:PCBM ratio in the ratio gradient experiment by UV-vis characterization of the R2R printed modules, an example of a 100 reflection peak profile with Gaussian and Lorentzian fits, distribution of extracted parameters from film with unvaried composition, variation of 100 reflection azimuthal spread with gradient, an example of GIWAXS data as recorded, and animations showing the raw SAXS data acquired are available online. See DOI: 10.1039/c2jm34596j

challenges that must be overcome, among which are an efficient sample geometry on flexible plastic substrates and an automated sampling method coupled to an automated data analysis protocol. Until now very little work has been dedicated to study R2R processing using X-rays. Of relevance, though, are the recent intensive studies by Schmidt-Hansberg *et al.* of the drying process of polymer solar cell active layer solutions, in a knife-coating setup (“doctor-blading”).<sup>7–9</sup> In these studies, X-ray diffraction of the drying film is measured in grazing incidence, while simultaneously monitoring the film thickness with a visible-light reflectometer. It was found for bulk heterojunctions of poly(3-hexyl)thiophene and [6,6]-phenyl-C61-butyric acid methyl ester (P3HT/PCBM) that the nanomorphology, phase separation, and crystallinity could be controlled by drying temperature through reduced molecular kinetics.<sup>7</sup> The effect of the P3HT:PCBM blend ratio on structural evolution of a drying doctor-bladed film indicated a strong molecular interaction between the two compounds, inhibiting P3HT  $\pi$ – $\pi$  packing at a large excess of PCBM.<sup>8</sup> At an excess of P3HT it was found that crystallization of PCBM is inhibited long past the solubility limit. The addition of a “poor solvent” for P3HT (cyclohexane) caused aggregation of P3HT in solution and consequently a broader orientation distribution of crystallites as compared to the substrate/surface-induced crystallization from pure chlorobenzene.<sup>9</sup> While clearly relevant for the understanding of coating of polymer solar cell active layers these studies are essentially batch experiments and, therefore, still limited with respect to R2R coating. For efficient exploration of the materials and processing parameter space, a truly R2R compatible implementation is required. In this work we demonstrate roll-to-roll characterization of active layers for polymer solar cells using synchrotron X-ray scattering by employing a simple unwinder-registration-winder unit and flexible plastic foil as the substrate for the measurements, as shown in Fig. 1. Three different gradient experiments show the possibilities for exploring the structural phase diagram of the multicomponent parameter space of polymer solar cell processing: donor/acceptor ratio, active layer thickness, and concentration of a solvent additive.

## Results and discussion

With thousands of measurements per experiment and diffraction data from area detectors, efficient analysis methods are required to evaluate the results. From inspection of the raw data we identified and extracted the following parameters from the data recorded on the Megapixel SAXS detector: integrated intensity, width, and position of the 100 reflection of P3HT, both from the peak centered on the surface normal corresponding to textured P3HT aligned with the substrate and for a segment of the diffraction ring corresponding to randomly oriented P3HT crystallites (Fig. 2). To observe the 100 reflection corresponding to textured P3HT, a relatively high X-ray incidence angle of 1.5° was required (see also the Experimental section) with the beam thus penetrating into the PET substrate causing strong background scattering in the WAXS detector. Combined with air scattering, this prevented the observation of diffraction signals from either P3HT or PCBM in the GIWAXS data recorded on the WAXS detector, and consequently, these data were not analyzed further. Thus, in the following, only data from the

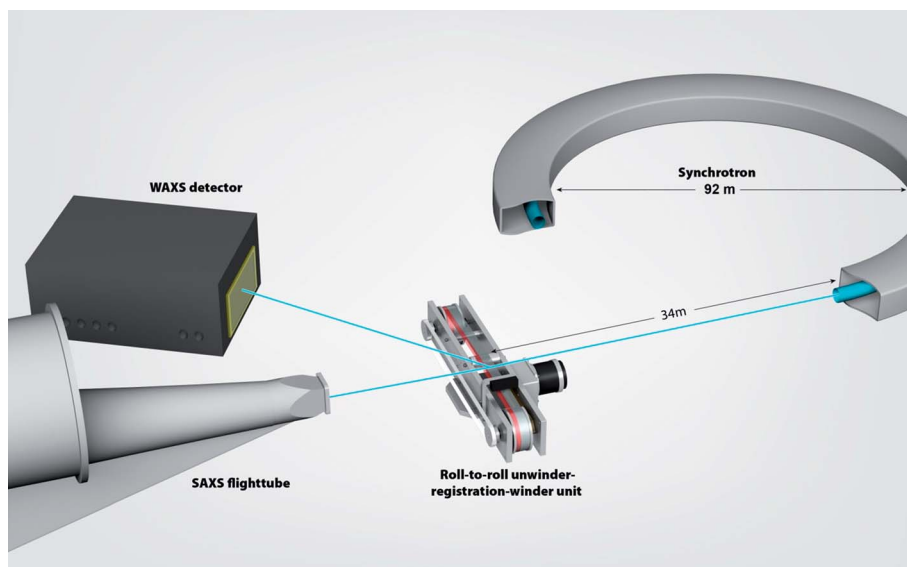
SAXS detector are discussed. For less crystalline polymers, it would likely be advantageous to choose a more shallow incidence angle to optimize the signal to noise ratio for GISAXS.

The parameters related to the P3HT 100 reflections were extracted by fitting a Gaussian function to the integrated peaks after subtracting a linear background function, yielding information about the amount of crystalline P3HT from the area of the fitted Gaussian, the crystalline coherence length from the fitted peak width through the Scherrer equation, and the lamellar packing density of the crystalline structure from the peak position. Although it is generally agreed that size–strain analysis on a single reflection cannot be used in a quantitative manner, we examined the possibility of separating peak broadening effects of size and strain by fitting a pseudoVoigt peak function where the Gauss–Lorentz mixing parameter might reveal useful information on trends in size/strain. We found, however, that the broad peaks are equally well fitted by “Gaussian” and “Lorentzian” pseudoVoigt functions therefore yielding very poorly determined mixing factors when fitted freely (see ESI Fig. S3†), and thus resorted to purely Gaussian fits to extract the parameters described above. The term coherence length is used to emphasize that these figures merely describe the limits to coherently diffracting regions without implying definite information on defects, strain or crystallite size.

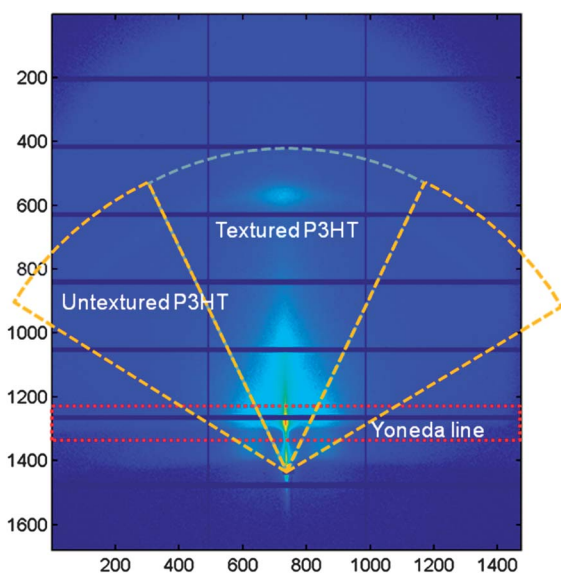
In all the experiments, crystallites with the lamellar stack aligned with the substrate clearly dominate, similar to the texture observed for spin coated P3HT.<sup>10</sup> Because of difficulties in obtaining an automated, stable fit to the generally weak signal from untextured crystallites, the coherence lengths for these were found to be too unreliable and were not analyzed further, and only intensities and *d*-spacings were extracted. In some cases, clear outliers can be identified, caused by tilting of the substrate foil when moving to the next sampling positions. These are obvious, however, as lying many standard deviations from the mean, and represent less than 5% of the data points. The effect of sample position instability is most severe with respect to the scattering intensity, and much less so with respect to reflection peak widths and position. The maximal theoretical bias of the 100 peak position corresponds to scattering from either side of the film width of 10 mm equaling 0.08 Å in *d*-spacing. In general, standard deviations half of this or less are observed, except for very weak peaks. For constant composition, we observe relative standard deviations of 0.1% for the 100 *d*-spacing of textured P3HT, 20.7% for the integrated intensity and 3.2% for the coherence length (see ESI Fig. S4–S6†).

The data analysis was performed post-acquisition, but we consider it feasible to apply these analysis methods online, to allow monitoring of meaningful physical parameters during R2R coating. Thanks to the large amount of sampling points, we get information about correlations between these properties and their correlation with the controlled parameter with very high statistical significance.

A small-angle scattering pattern along the substrate surface (*i.e.* along  $q_{xy}$ ) was extracted by integrating the scattered intensity in a region around a fixed  $q_z$  corresponding to the position of the Yoneda peak (Fig. 2). For each point we integrated data from four 100 ms exposures, but sufficient intensity is acquired in a single exposure. This allows for measurements with continuous foil movement at speeds of up to 6 m min<sup>−1</sup> with the same spatial resolution as in the present experiments, thus enabling real-time



**Fig. 1** Artist's rendition of the experiment showing the X-ray source (the synchrotron), the roller unit, and the detectors (WAXS detector and SAXS flight tube entry). Note that the WAXS data were found not to provide usable data in the reported experiments (see explanation below).



**Fig. 2** A SAXS pattern from an R2R experiment showing the integration regions used to extract structural parameters of the film. The central region, covering an azimuthal angle of  $50^\circ$ , was chosen to represent the scattering of P3HT crystallites with the lamellar stack aligned with the substrate ("textured P3HT"). The two regions to the side, outlined in yellow, were used to integrate scattering from P3HT crystallites with random orientation ("untextured P3HT"). The rectangular region, outlined in red, corresponds to the region integrated to extract the GISAXS pattern along the "Yoneda line".<sup>12</sup> The numbering indicates the pixels. For an example of an integrated peak profile of the textured P3HT reflection, please refer to the ESI.†

analysis of coating processes. An optimized laboratory instrument<sup>11</sup> can deliver  $10^7$ – $10^8$  photons on the sample *i.e.* 4–5 magnitudes lower flux as compared to an insertion device synchrotron beam line. The higher divergence of the laboratory instrument means that more crystallites are in diffraction condition for polycrystalline films at a given incidence angle. Accepting

a lower spatial resolution (*e.g.* an exposure every 5 cm), gradient experiments as the ones reported here could be completed in a few days with an exposure time of 1000 s.

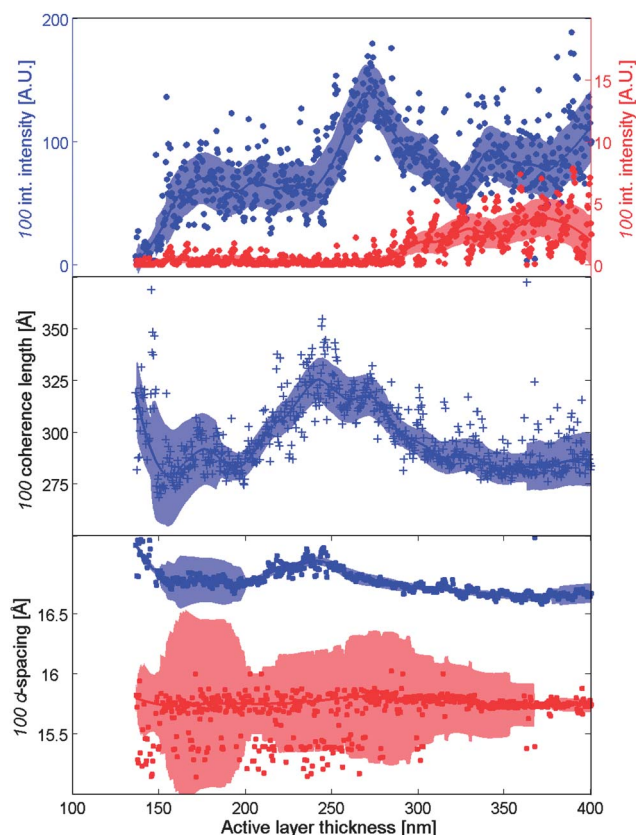
The GISAXS patterns integrated along the Yoneda line<sup>12</sup> are very susceptible to variations in the sample position, and contain a substantial scattering contribution from the substrate because of the high incidence angle. We have consequently only evaluated large changes in scattering intensity, as was observed in the ratio gradient experiment (discussed below).

### Thickness gradient

The parameters for the textured and untextured P3HT 100 peaks are shown as a function of nominal dry film thickness in Fig. 3. A smoothed line to guide the eye is added to each dataset by calculating a weighted linear least squares local regression using a 2<sup>nd</sup> degree polynomial model across a data span of 15% of the total number of data points. Outliers outside six mean absolute deviations are assigned zero weight. The lighter colored band shows the standard deviation of the data points in the smoothing span centered on the corresponding data point, with respect to the smoothed mean. Some outliers representing very poor fits to the data are outside the plot region, but increase the standard deviation significantly (*e.g.* *d*-spacings of untextured crystallites in thin films, lower panel of Fig. 3).

The scatter in the data, caused by sample movement and film inhomogeneity, does not hide the clear trends, showing that the amount of crystalline textured P3HT increases with film thickness, but with a distinct maximum at 272 nm (top panel). With a larger thickness, untextured crystallites appear. The textured crystallite coherence length shows a broad maximum for a slightly thinner film, at 246 nm (Fig. 3, middle panel). For both textured and untextured crystallites, the lamellar spacing decreases slightly for the thickest films but with a maximum at 240 nm for the textured crystallites (lower panel).

In the scatterplots (Fig. 4) we observe a positive correlation between the lamellar *d*-spacing and the coherence length (top



**Fig. 3** Parameters of the crystalline P3HT *100* reflections shown as a function of the controlled gradient parameter, thickness. Data for the textured crystallites are shown in blue, for the untextured crystallites in red. Coherence lengths for untextured crystallites are not shown. A smoothed line is shown to guide the eye, with the associated band of one standard deviation of the data points with respect to the smoothed mean (see also main text for further explanation).

panel), but no correlation with the scattering intensity (middle panel). There is a positive correlation between integrated intensity and coherence length (lower panel). This is to be expected for a reflection from a population of a textured, semi-crystalline polymer, as in this case, both coherence length and integrated intensity will be related to the crystallinity of the polymer. The points corresponding to the smallest integrated intensity (below  $\sim 15$ , mostly dark blue) represent measurements where the *100* peak was ill defined, because the sample foil tilted during movement to a new measuring position. The recorded values in these points are thus viewed to be less accurate.

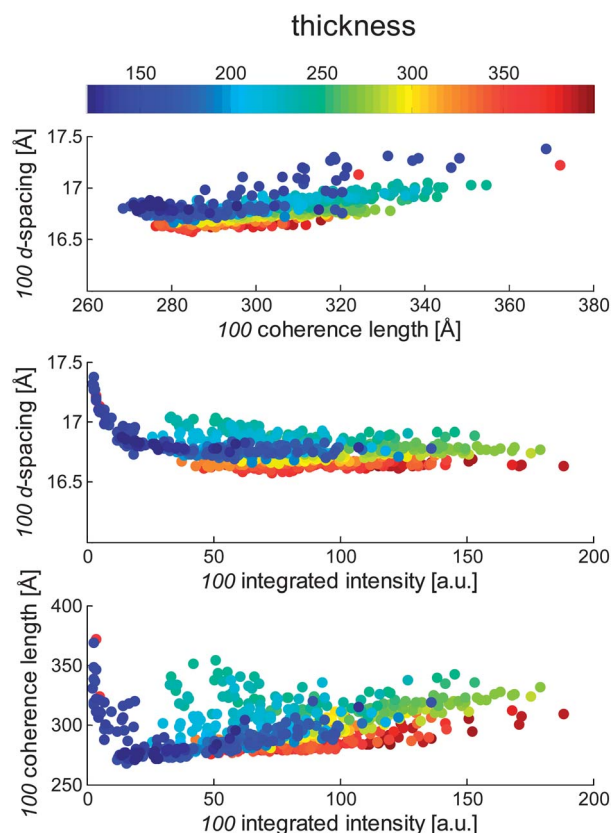
To summarize, we observe that, (1) up to 272 nm, the crystalline P3HT component of the active layer film is completely dominated by the textured population of crystallites presumably formed from nuclei in contact with the substrate, with the amount increasing with film thickness. (2) The largest of these crystallites occurs in films of 225–275 nm thickness. (3) The thickest films with longer drying times allow better organization of the polymer chains, and thus a shorter lamellar stacking, although the largest crystallites have the largest lamellar spacing, presumably due to steric hindrance during crystallization. (4) In films thicker than 275 nm, kinetics favor the formation of new crystalline nuclei in the drying film, with random orientation, and (5) these untextured crystallites

adopt a different structure polymorph than the textured crystallites, presumably with partly interdigitated side chains as evidenced by very short lamellar spacings (form II identified by Prosa *et al.*<sup>13</sup>), or, the monoclinic structure identified by Brinkmann *et al.*<sup>14</sup> also characterized by a short lamellar packing distance.

### Ratio gradient

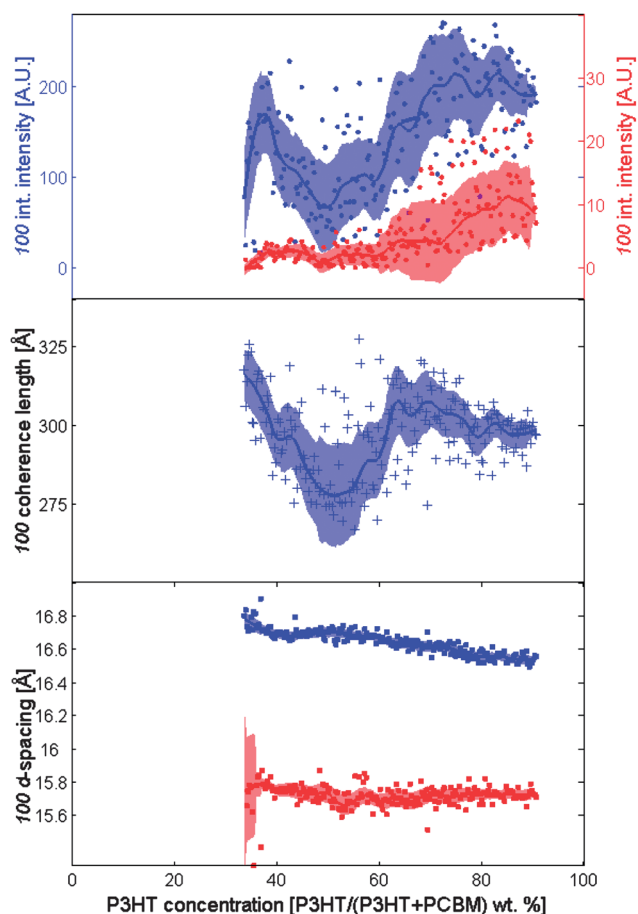
The *100* peaks, corresponding to both textured and untextured crystallites, first appear at a ratio of 1 : 2 between P3HT and PCBM (Fig. 5). At first, the scattering intensity passes through a local maximum at about 40% P3HT and again increases for the highest P3HT:PCBM ratios above 1 : 1. The *100* coherence length of the textured crystallites shows a broad minimum at 1 : 1 ratio, whereas the lamellar *d*-spacing decreases with P3HT concentration, through a local minimum at  $\sim 42$  wt% P3HT. The lamellar *d*-spacing of the untextured crystallites is constant at the very short distance of 15.7 Å in corroboration of the results obtained in the thickness gradient experiment.

Scatterplots show that the coherence length and lamellar *d*-spacing are uncorrelated (but the largest coherence lengths seen in the thickness gradient experiment are not observed here), whereas there is a negative correlation between integrated intensity and *d*-spacing (Fig. 6, top and middle panels). There is a



**Fig. 4** Scatterplots showing relations between the parameters extracted from P3HT *100* reflections of textured crystallites for the thickness gradient experiment. Top panel: crystallite coherence length vs. *d*-spacing. Middle panel: integrated intensity vs. *d*-spacing. Lower panel: integrated intensity vs. crystallite coherence length. The color grading corresponds to the nominal film thickness, indexed as shown on the color bar at the top of the figure.





**Fig. 5** Parameters of the crystalline P3HT 100 reflections shown as a function of the controlled gradient parameter, P3HT concentration [P3HT/(P3HT + PCBM) by weight]. The data for the textured crystallites are shown in blue, for the untextured crystallites in red. Coherence lengths for untextured crystallites are not shown. No data are available below 37% P3HT where there is no P3HT diffraction signal.

clear positive correlation between integrated intensity and the 100 coherence length (Fig. 6, lower panel).

The GISAXS patterns show a very dramatic change at exactly the point where P3HT crystallites appear, at the ratio of 1 : 2 P3HT:PCBM (Fig. 7).

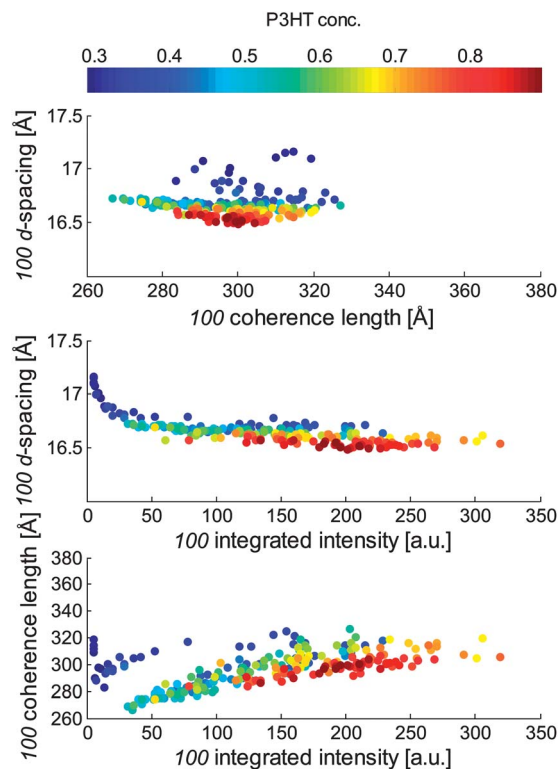
The GISAXS intensity increases strongly and abruptly, indicating the sudden appearance of nanostructured inhomogeneities in electron density. These observations confirm the earlier findings by Schmidt-Hansberg *et al.* who found that strong intermolecular interaction between P3HT and PCBM may inhibit the crystallization of the minority component (in their case, PCBM).<sup>9</sup> Up to a ratio of 1 : 2, P3HT and PCBM are mixed on the molecular scale, but at a higher P3HT content, crystallites of P3HT form, creating nanoscale inhomogeneities which give a strong SAXS signal. The abrupt change is currently subject to further study and while corroborated by independent research groups<sup>9</sup> a possible explanation in this case is that it is also a result of the short drying time (~2 seconds) in the coating experiment. With fast drying the crystallization threshold is likely to be defined within a very narrow range in composition space.

The most important observations we note for the ratio experiment are as follows: (1) the P3HT crystallites show the smallest

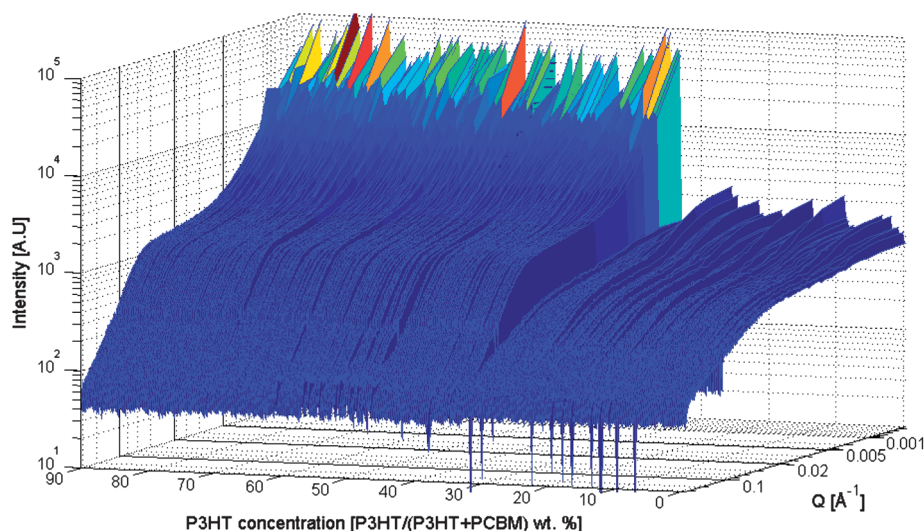
coherence length at a 1 : 1 P3HT:PCBM ratio. (2) P3HT crystallizes only above a 1 : 2 ratio with PCBM, and crystallinity increases just slightly at higher ratios. (3) The lamellar spacing is consistently larger for textured P3HT as compared to randomly oriented P3HT, which indicates that PCBM only interferes with the polymer chain packing in the textured crystallites. The short lamellar spacing of untextured crystallites indicates interdigitation of side chains as observed also in the thickness gradient experiment. (4) The lamellar spacing decreases with larger ratios of P3HT to PCBM showing a lessened effect of molecular interaction.

### Additive gradient

The effect of solvent additives is variously described as improving phase separation, controlling donor–acceptor coherence lengths, or improving crystallinity. An example of the use of solvent additives is that of 1-chloronaphthalene (CN) for P3HT/PCBM active layer coating from *o*-dichlorobenzene (DCB).<sup>15</sup> CN is a high boiling point solvent (259 °C) as compared to chlorobenzene (CB, 131 °C) and DCB (181 °C), and fullerenes have a much better solubility in CN. Chen *et al.* concluded that these properties accounted for an improved solar cell performance because of improved phase separation and higher crystallinity of the polymer as deduced from grazing-incidence X-ray diffraction data taken along the surface normal of spin coated films.<sup>15</sup>



**Fig. 6** Scatterplots showing relations between the parameters extracted from P3HT 100 reflections of textured crystallites for the P3HT/PCBM ratio experiment. Top panel: crystallite coherence length vs. *d*-spacing. Middle panel: integrated intensity vs. *d*-spacing. Lower panel: integrated intensity vs. crystallite coherence length. The color grading corresponds to the P3HT concentration P3HT/(P3HT + PCBM), indexed as shown on the color bar at the top of the figure.



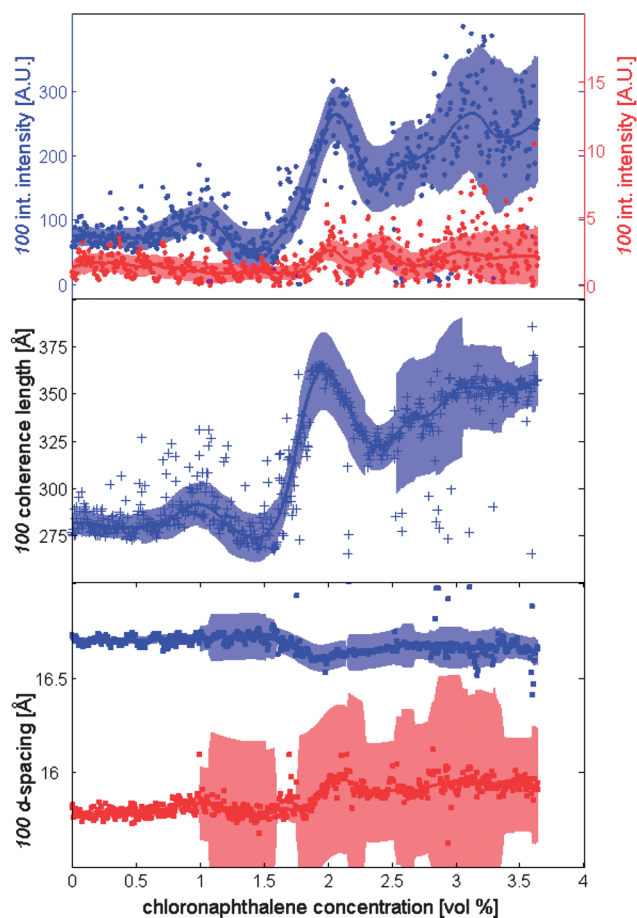
**Fig. 7** GISAXS patterns from the ratio gradient experiment. The point where the scattering intensity increases dramatically corresponds to the P3HT concentration where P3HT crystallizes ( $\sim 37$  wt%).

In the present study, with the concentration of CN increasing from 0 to 3.5%, we observe several distinct and rapid changes, corresponding to changes in polymer texture and crystallinity.

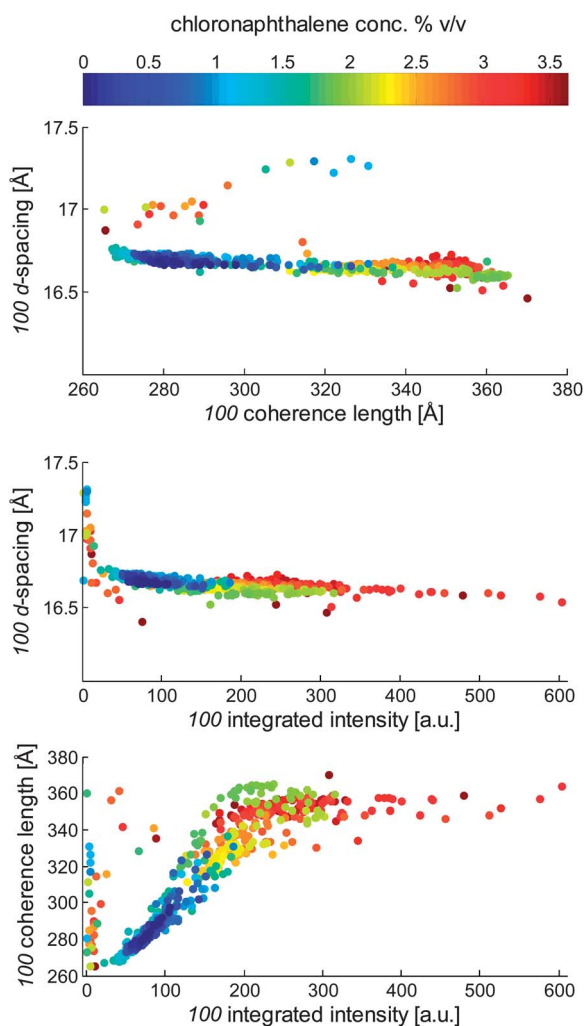
The integrated intensity of the  $100$  peak from the textured P3HT crystallites increases with addition of chloronaphthalene (CN), with local maxima at 1.0, 2.0 and 3.2 vol% (Fig. 8). The intensity of the  $100$  peak of untextured crystallites also shows a weak increase with CN concentration, albeit with a large scatter of values. The coherence length of textured crystallites is positively correlated with the scattering intensity up to about 2 vol% CN (Fig. 8, top and middle panels). The effect of CN on the lamellar spacing is rather striking, with a clearly significant decrease of the  $100$  lattice spacing of the textured crystallites and an increase of the  $100$  lattice spacing of untextured crystallites at 1.5 to 2.0 vol% CN. The large standard deviations for the lamellar spacings of untextured crystallites are due to a relatively high number of outliers (outside the plot range) due to poor fits of these mostly weak peaks. Nevertheless, a positive shift of about  $0.1 \text{ \AA}$  at 2 vol% CN addition appears to be significant. The average  $d$ -spacing of untextured crystallites below 1.5 vol% CN addition is  $15.80(4) \text{ \AA}$  and  $15.92(8) \text{ \AA}$  above 2.5 vol% CN addition (standard deviations in parentheses, excluding outliers).

From the scatterplot of P3HT  $100$  coherence length vs. lattice spacing we observe a weak negative correlation of the lamellar spacing with the coherence length, and further that the large coherence lengths appear for a CN concentration of 2 vol% and above (Fig. 9, top panel). Likewise, we observe a weak negative correlation between scattering intensity and lattice spacing with the highest intensities above 2 vol% CN (Fig. 9, middle panel). In the lower panel of Fig. 9, we observe the relationship between the scattering intensity and coherence length, with a clear positive correlation up to about 2 vol% CN, above which we see a constant coherence length.

Thus, we find that the addition of a solvent with high boiling point (1) clearly improves crystallinity and (2) facilitates crystal growth, while (3) allowing time for the polymer to adopt a good molecular packing as evidenced by the short lamellar  $d$ -spacing in corroboration of the results obtained by Prosa *et al.*<sup>13</sup> (4) The



**Fig. 8** Parameters of the crystalline P3HT  $100$  reflections shown as a function of the controlled gradient parameter, chloronaphthalene concentration. The data for the textured crystallites are shown in blue, for the untextured crystallites in red. Coherence lengths for untextured crystallites are not shown.



**Fig. 9** Scatterplots showing relations between the parameters extracted from crystalline P3HT 100 reflections for the additive experiment. Top panel: crystallite coherence length vs.  $d$ -spacing. Middle panel: integrated intensity vs.  $d$ -spacing. Lower panel: integrated intensity vs. crystallite coherence length. The color grading corresponds to the CN concentration, indexed as shown on the color bar at the top of the figure.

strongest effect is realized at 2 vol% CN, and not much is gained by a higher percentage of additive. (5) Also at 2 vol% CN and higher concentrations, the lamellar spacing of untextured crystallites increases, which may indicate that CN facilitates molecular interaction between PCBM and P3HT, partly interfering with side-chain ordering of the polymer.

## Conclusions

We have demonstrated an efficient means of characterizing polymer crystallinity and texture of R2R coated polymer solar cell active layers as a function of a variety of controlled processing parameters. This was done by recording a high spatial density of SAXS data from the gradient coated films, varying thickness, P3HT:PCBM ratio, and CN additive concentration over 10 meters substrate length, using a dedicated unwinder-registration-winder unit. In this manner we were able to identify significant changes to the polymer crystalline texture as a function of active layer thickness, P3HT:PCBM ratio and

processing additive concentration. We find that highly textured P3HT dominates in films of up to about 270 nm thickness. In thicker films, we find increasing amounts of untextured P3HT crystallites, adopting a different structural form with a shorter lamellar spacing. An addition of 2 vol% chloronaphthalene to the processing solvent enhances the crystallization of P3HT.

This type of information can be correlated with other R2R characterization methods, including IPCE measurements, *e.g.* we find it significant that the minimal coherence length of P3HT coincides with the optimal 1 : 1 ratio with PCBM, found in many other studies. Such correlations may facilitate fast optimization of new material combinations. We envisage that the method may be extended to online coating characterization by supplementing the roller unit with the appropriate microsyringe pumping arrangements. More detailed structural information will be available from the WAXS detector and from the GISAXS signal in the SAXS detector by performing scans at several (more shallow) X-ray incidence angles, significantly attenuating scattering from the substrate. An obvious extension of the method is for partially completed multilayer solar cell stacks which will allow a direct correlation with cell performance. Microcrystalline, inorganic materials such as the transparent conducting oxide electrode and oxide blocking layers will not have substantial scattering in the small angle regime. Finally, a subject for further study using GISAXS is crystallization phenomena as a function of drying kinetics and additives.

## Experimental

### Materials

Poly-3-hexylthiophene with a molecular weight of 40 kDa and regioregularity of 96% was obtained from BASF (Sepiolid P200), PCBM was obtained from Solenne BV (99%), chlorobenzene was of analytical grade (Aldrich, purity 99%), and chloronaphthalene was of reagent grade (Aldrich, 97%). The substrate was polyethylene terephthalate (PET) with a thickness of 130 micron and a web width of 305 mm (Dupont-Teijin, Melinex ST506). *Roll-to-roll coating*: the method followed that described in the literature.<sup>2</sup> The foil was labeled using an ink jet barcode printer with a unique label for each of the 6 stripes on the foil. Both a machine-readable barcode and a human-readable alphanumeric text string were written every 10 cm along the foil. The foil was labeled with 6 sets of 5-digit barcodes with the first digit describing the experiment number and the last 4 digits being incremented for every 10 cm. After coating of the experiments the foil was sliced using a roll-to-roll cutting machine into rolls that were 30 mm wide containing only the barcode and the 13 mm wide coated stripe for X-ray testing.

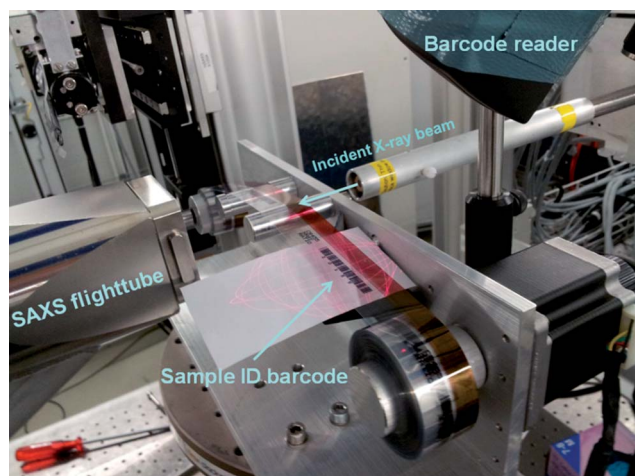
Three different types of coating experiments were carried out in duplicate: ratio, thickness and additive experiments. For coating the web speed was 2 m min<sup>-1</sup> with an oven temperature of 60 °C (2 m oven length). After experiment 1 had been carried out the foil was rewound and the same foil was passed through the machine while carrying out the next experiment. After the last coating experiment the foil was passed through an oven at 140 °C (2 m oven length) to anneal all stripes identically and to simulate conditions typically employed during roll-to-roll manufacture.<sup>16–21</sup> The coating setup employs a mini slot-die coating head



and two piston pumps with a flow resolution of 10  $\mu\text{L}$ . The output from each pump is combined in a mixing tee and fed to the mini slot-die coating head. The coated width was 13 mm and the flow was fixed at 250  $\mu\text{L min}^{-1}$ . In the ratio experiments, pump A contained a chlorobenzene solution of P3HT (20 mg  $\text{mL}^{-1}$ ) and pump B PCBM (20 mg  $\text{mL}^{-1}$ ) in chlorobenzene. In the thickness experiment, pump A contained P3HT (20 mg  $\text{mL}^{-1}$ ) and PCBM (20 mg  $\text{mL}^{-1}$ ) in chlorobenzene while pump B contained pure chlorobenzene. The wet film thickness is 10  $\mu\text{m}$  corresponding to a starting dry thickness of 400 nm assuming a dry film density of 1.1 g  $\text{cm}^{-3}$  (*cf.* similar experiments).<sup>2</sup> In the additive experiment, pump A contained P3HT (20 mg  $\text{mL}^{-1}$ ) and PCBM (20 mg  $\text{mL}^{-1}$ ) in chlorobenzene while pump B contained P3HT (20 mg  $\text{mL}^{-1}$ ) and PCBM (20 mg  $\text{mL}^{-1}$ ) in chlorobenzene with 1-chloronaphthalene (5% v/v). All solutions were stirred at 70  $^{\circ}\text{C}$  and immediately filtered (0.45 micro Teflon filter) before the coating experiment. In the experiment the coating was started while constantly pumping with either pump A or pump B and once the coating had been established as stable, the gradient mixing of pump A and pump B was commenced and continued over a length of 10 m (100 barcodes) upon completion of the gradient the coating was continued with constantly pumping pump B or pump A. After the X-ray experiments had been carried out a 4 cm piece of foil was cut every 1 meter and the material dissolved in a constant volume of chloroform (4 mL) that was subsequently analyzed using ultraviolet-visible spectroscopy (UV-vis). In this manner the start and end points of the gradient experiments were accurately confirmed (see also ESI† available online).

### Roll-to-roll unwinder-registration-winder unit

The device shown in Fig. 10 consists of an unwinder and winder roll, handling up to 15 m of coated PET substrate foil, 130  $\mu\text{m}$  thick. The foil is held tight to the central aluminum cylinder that serves as the X-ray measuring position. A barcode reader scans the foil continuously, registering the module number printed on



**Fig. 10** The R2R unit in action at the cSAXS beam line, mounted on the sample stage hexapod. The beam flight tube exit is seen on the right and the SAXS flight tube entry on the left. On the substrate foil, the red active layer film can be seen as well as the bar code. The scanning pattern of the bar code reader laser can just be made out over the bar code.

the substrate, thus keeping track of the position along the gradient experiment. The recorded module numbers are stored in the header of the X-ray data files. A stepper motor advances the foil as controlled by the beam line control software.

The entire unit was mounted on a hexapod allowing full control of the positions and tilt with respect to the X-ray beam (Fig. 10). Two modes of operation were used: first a move until a barcode was read, followed by a series of X-ray measurements at shorter spacings on the foil. This method proved somewhat unreliable, as the reading of barcodes would fail at times. We consequently changed to a mode where the foil was advanced at a constant fixed amount, followed by X-ray measurements, repeatedly, while continuously reading out barcodes for registration of the position.

### X-ray methods

The experiment was carried out at the cSAXS beam line (X12SA) at the Swiss Light Source. The scattering signal was recorded on two detectors (Fig. 1). A 2 Megapixel Pilatus detector<sup>22</sup> at 2.1 m from the sample behind an evacuated flight tube for measuring the small-angle X-ray scattering signal at grazing incidence (GISAXS) and a 100k Pilatus detector<sup>22</sup> positioned in the foil substrate plane covering angles from 13 $^{\circ}$  to 26 $^{\circ}$  to the direct beam for measuring the wide-angle X-ray scattering signal (GIWAXS). At each sampling position, four exposures of 0.1 s were acquired allowing 3 ms for readout after each. The X-ray energy was 11.1 keV. No corrections were applied to the data. In principle, both Lorentz and polarization corrections apply, but as we are only considering variations relating to the 100 reflection in a narrow region of reciprocal space, this was deemed to be unnecessary. As the incidence angle was far above the critical angle for total reflection, the scattering intensities can be treated in the kinematical approximation,<sup>23</sup> *i.e.* not requiring a correction for effects of refraction.<sup>24</sup> From the experiment geometry we estimate an instrumental broadening amounting to about 10% of the 100 peak width in reciprocal  $\text{\AA}$ , corresponding to a negligible 1  $\text{\AA}$  in real space assuming a Gaussian instrumental broadening.<sup>25</sup>

To obtain a signal from P3HT crystals oriented with lamellar stacks parallel to the substrate, we found that it was necessary to use an X-ray incidence angle relatively close to the angle fulfilling the Bragg condition for the 100 reflection ( $\theta = 1.92^{\circ}$ ). The lowest incidence angle giving a satisfactory scattering intensity from the 100 reflection was found at 1.5 $^{\circ}$ . This does however compromise the GISAXS and GIWAXS signals, because the beam penetrates into the PET substrate, giving substantial background scattering (an example of GIWAXS data is shown in the ESI†). Animations showing the raw SAXS data acquired are available online.

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